

Effect of geometrical misalignment on the MTF measurement

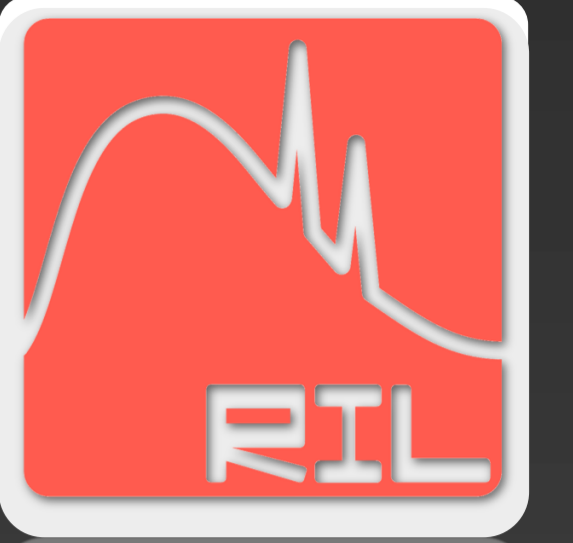


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Background

- The modulation transfer function (MTF) has been widely used to characterize the spatial resolution of x-ray imaging systems. The MTF can be obtained from the Fourier transform of line-spread function (LSF) of the x-ray imaging system with a slit-camera
- Geometrical misalignment of the slit camera with respect to the beam geometry can distort the measured LSF and the resulting MTF
- This error can occur vulnerably in the magnification imaging

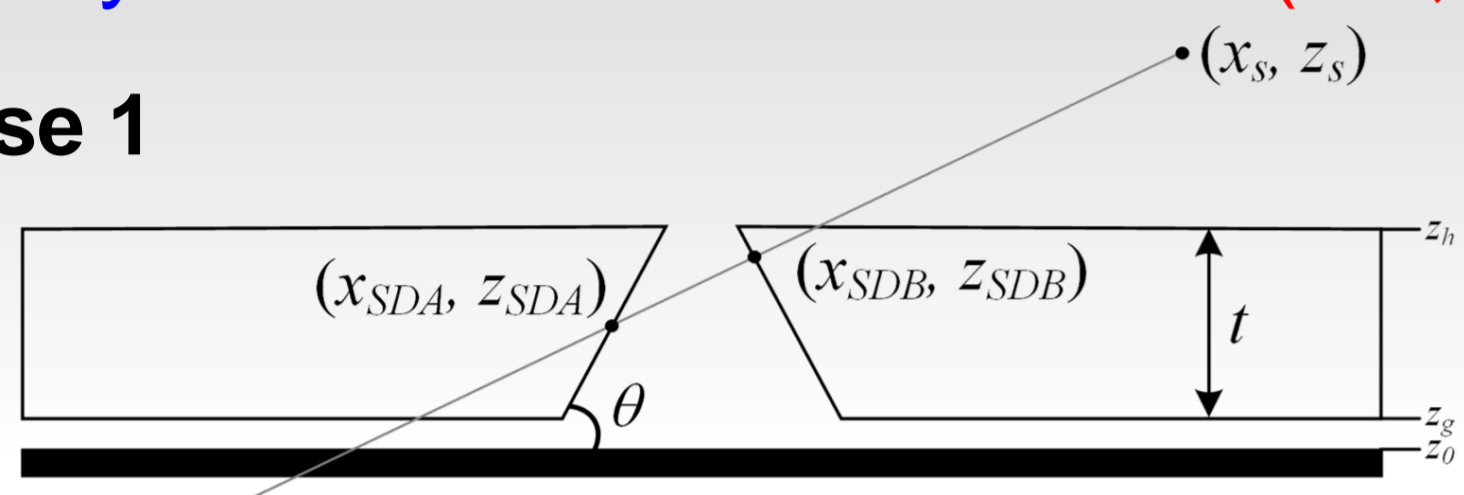
Research Objective

- We investigate experimentally the effects of **geometrical misalignments** on the MTF
 - Tilt-angle
 - Magnification
 - Application

Materials and Methods

Analytic model for slit thickness (i.e., l)

Case 1

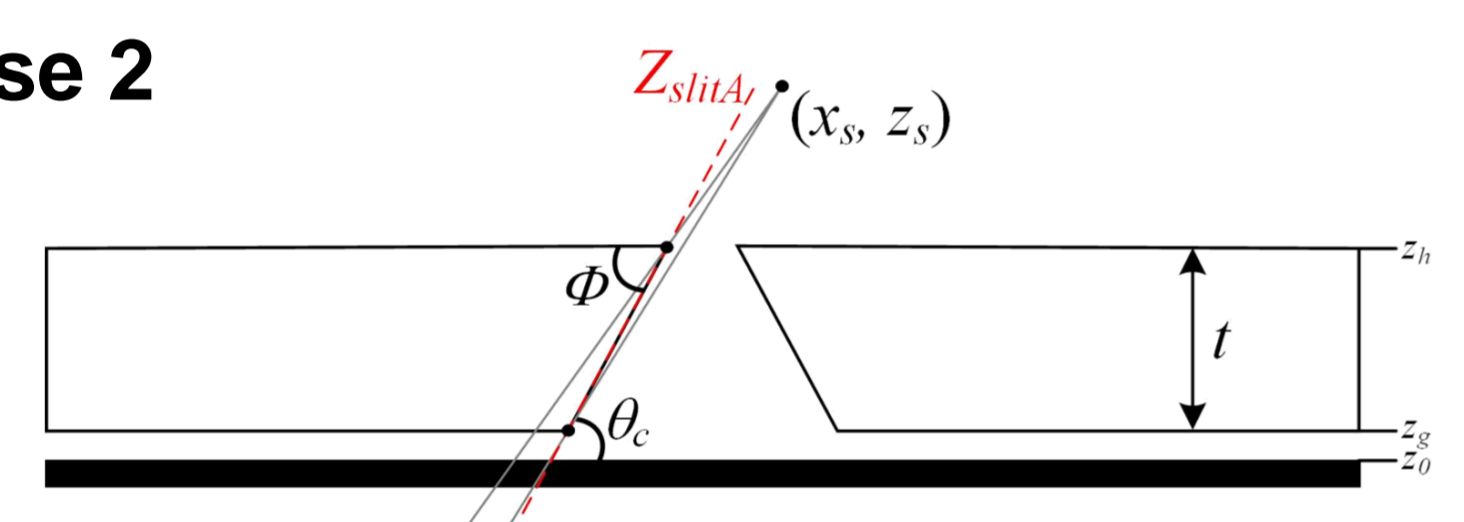


$$l_1 = \sqrt{\left(\frac{(z_g - z_s)}{\tan\theta} + x_s - x_{SDA}\right)^2 + (z_{SDA} - z_g)^2}$$

$$l = l_1 + l_2$$

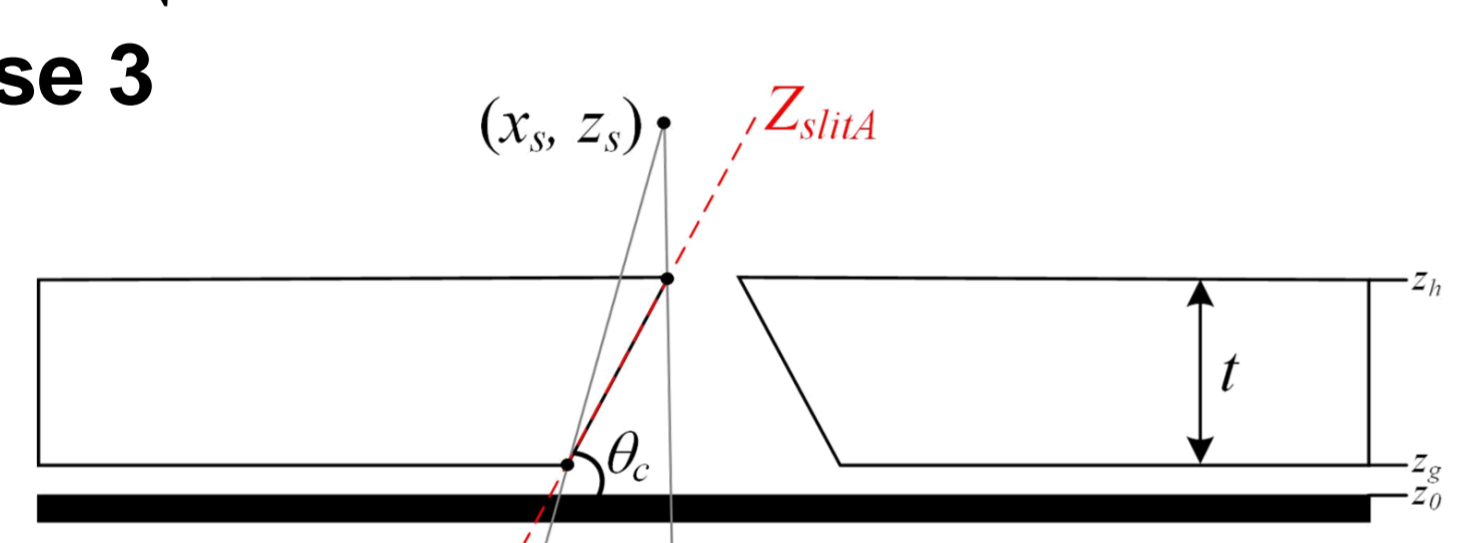
$$l_2 = \sqrt{\left(\frac{(z_h - z_s)}{\tan\theta} + x_s - x_{SDB}\right)^2 + (z_{SDB} - z_s)^2}$$

Case 2



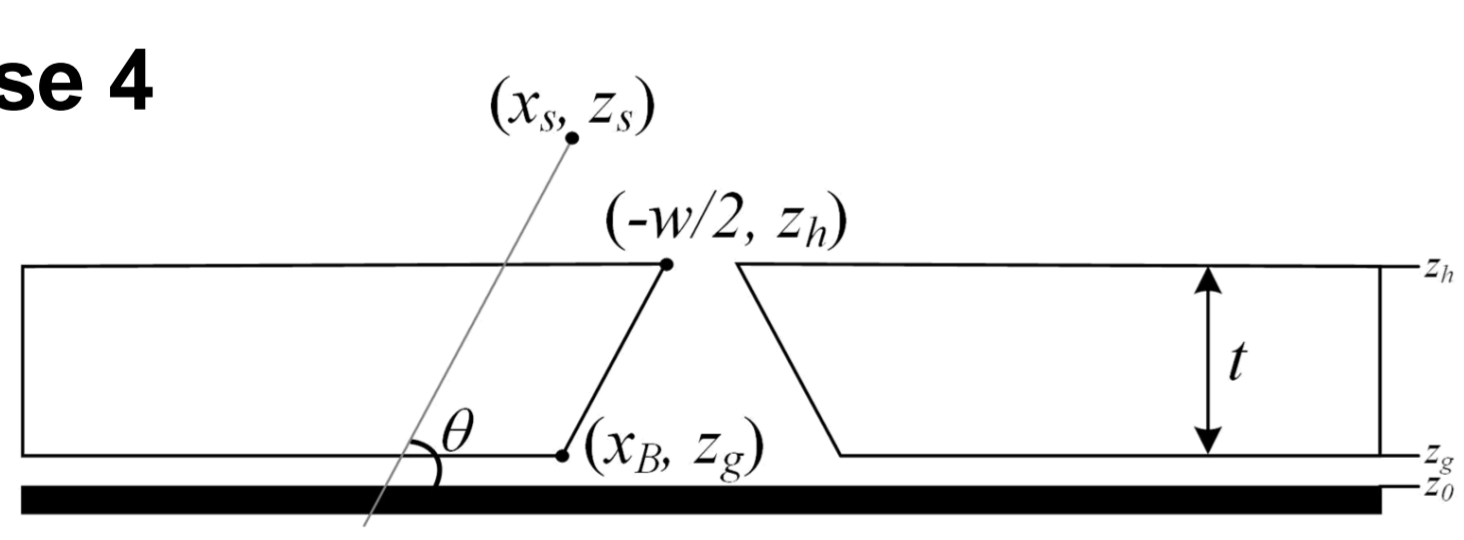
$$l = \sqrt{\left(\frac{(z_g - z_s)}{\tan\theta} + x_s - x_{SDA}\right)^2 + (z_{SDA} - z_g)^2}$$

Case 3



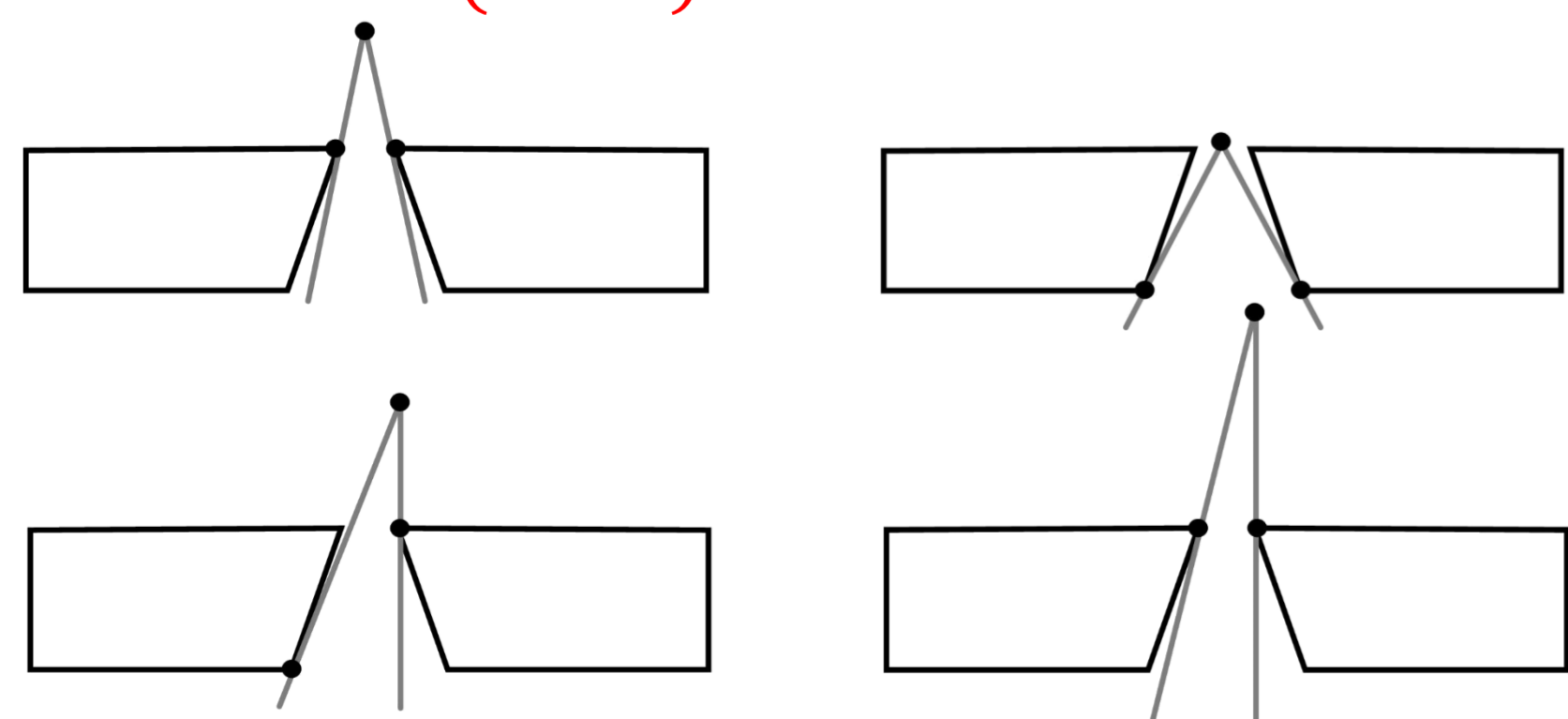
$$l = \sqrt{\left(\frac{(z_h - z_s)}{\tan\theta} + x_s - x_{SDA}\right)^2 + (z_{SDA} + z_s)^2}$$

Case 4



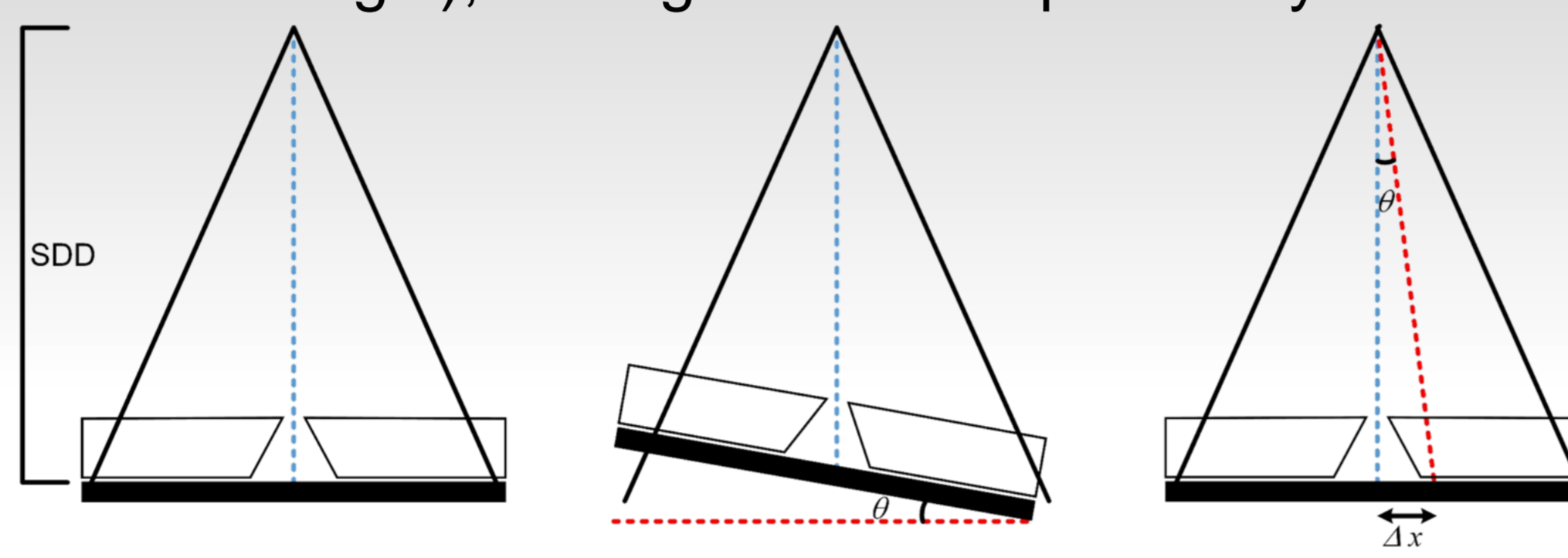
$$l = t \times \sqrt{\left(\frac{1}{\tan\theta}\right)^2 + 1}$$

Case of the x-ray passes through the internal slit ($l = 0$)

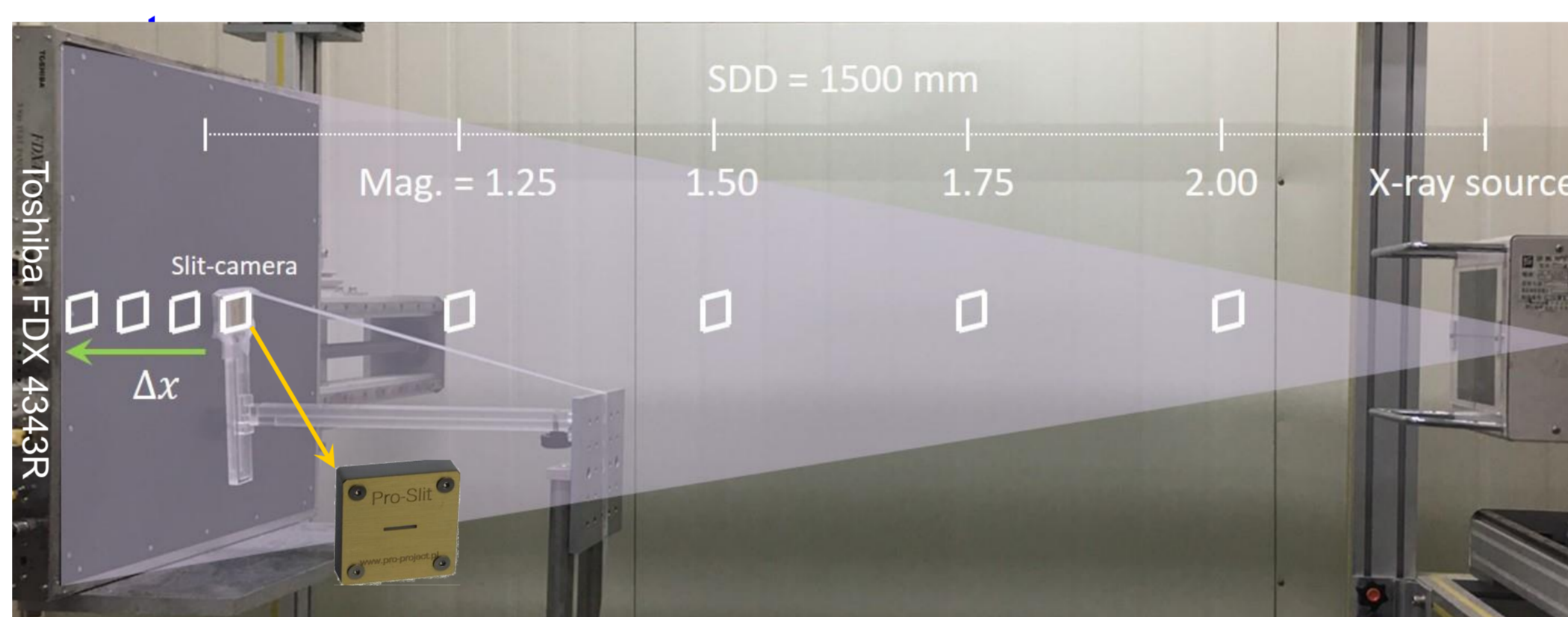


Tilt-angle measurement (Δx)

- When jaw-angle and tilt-angle are the same (i.e. critical-angle), tilt-angle can be replaced by the Δx



Experimental setup

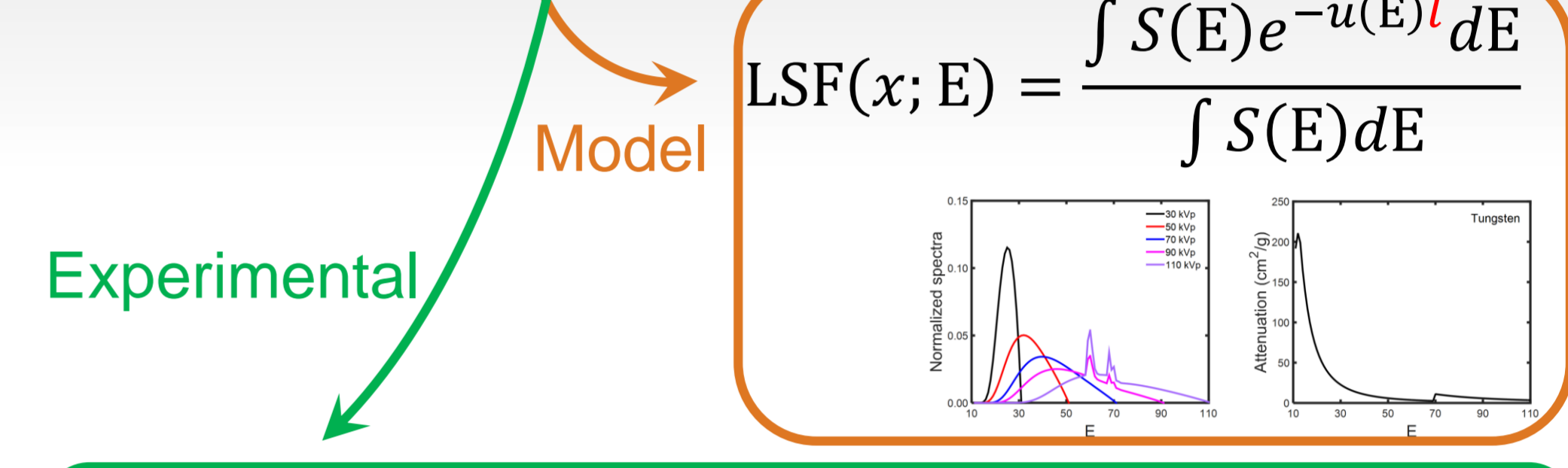


Measurements and analysis

MTF

- The MTF could be calculated by fast Fourier transforming the LSF obtained from the slit image

$$MTF(u) = FT\{LSF(x)\}$$



Effective MTF

$$f' = mf$$

(where, m is magnification)

Effective aperture

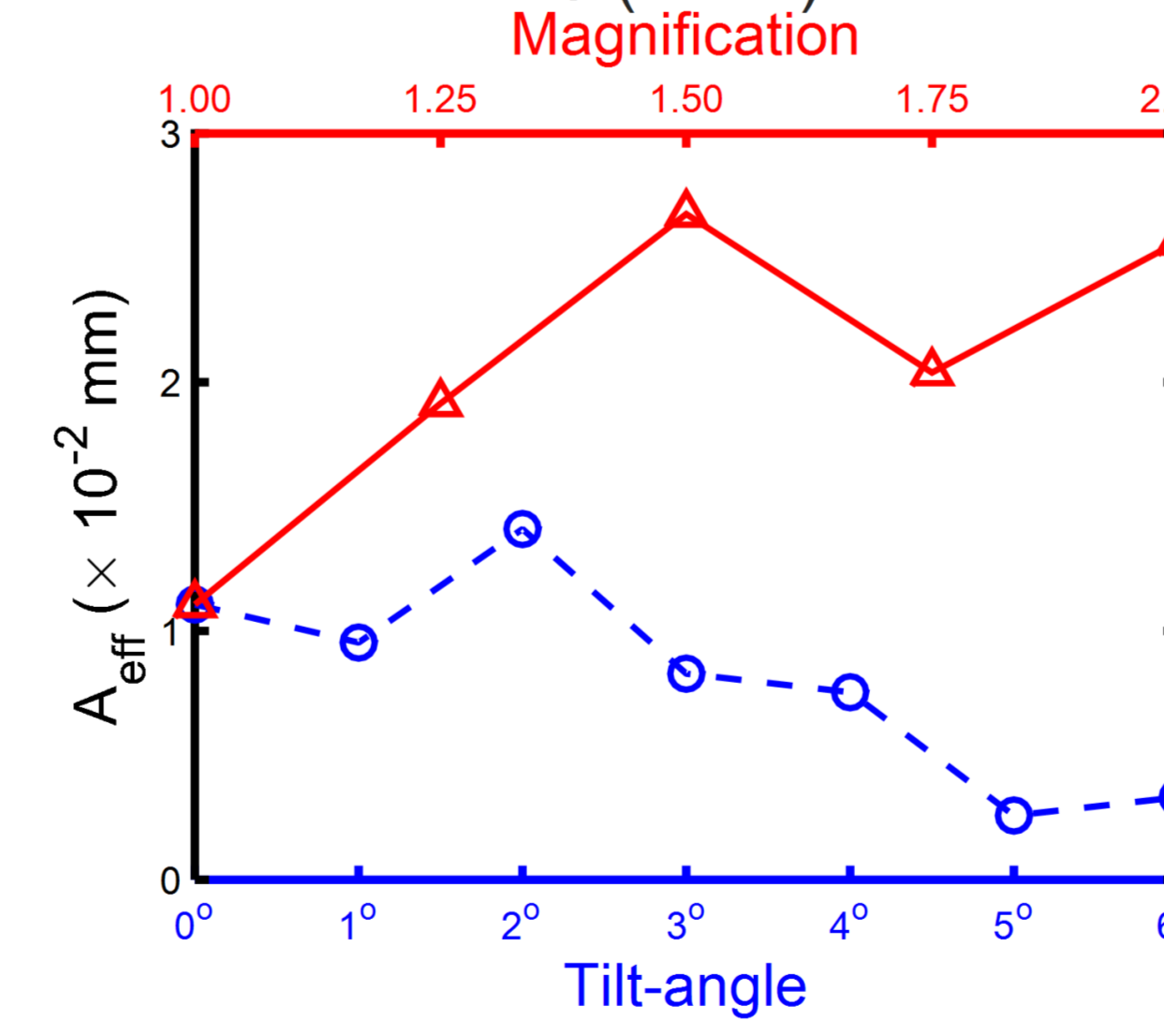
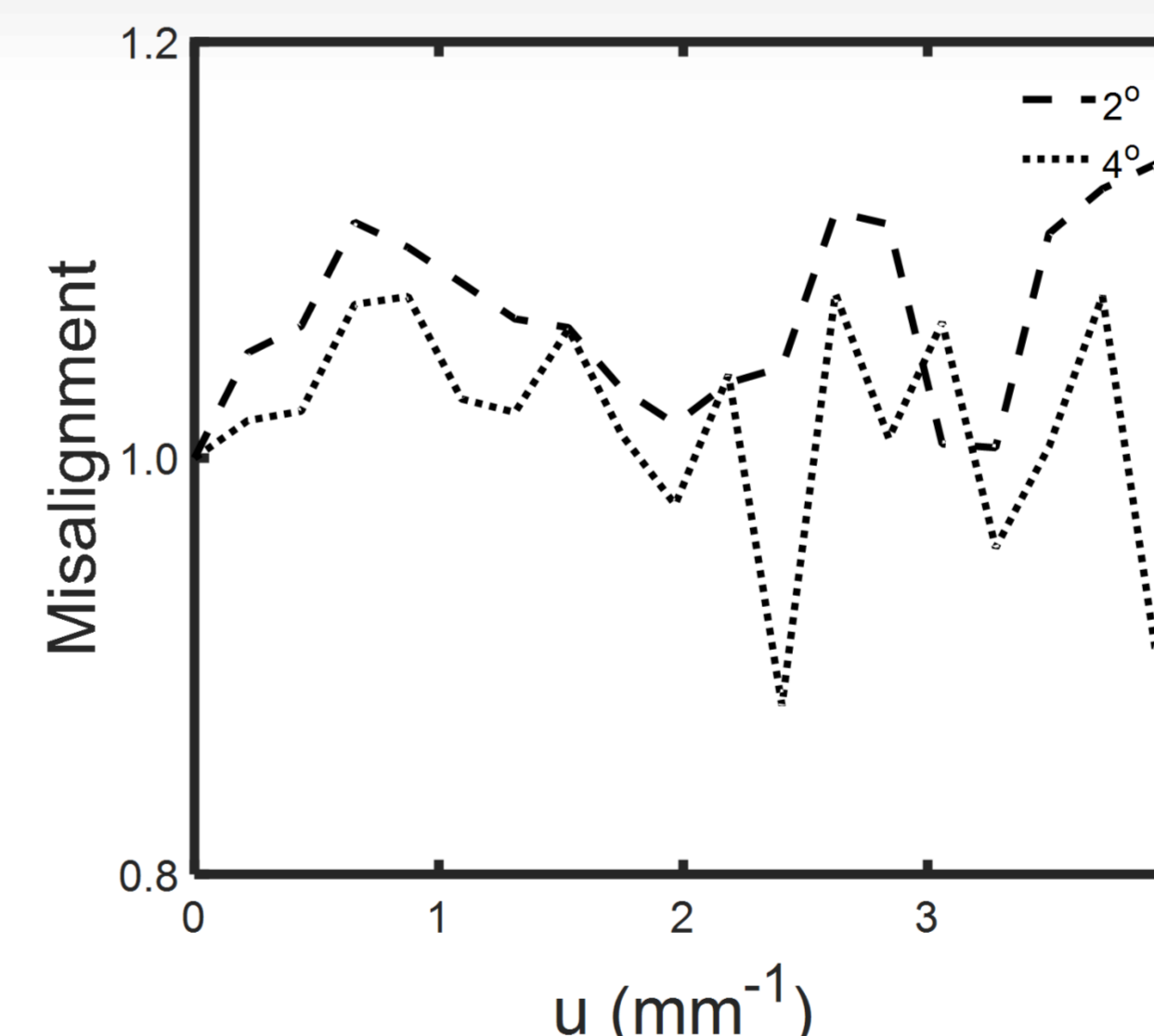
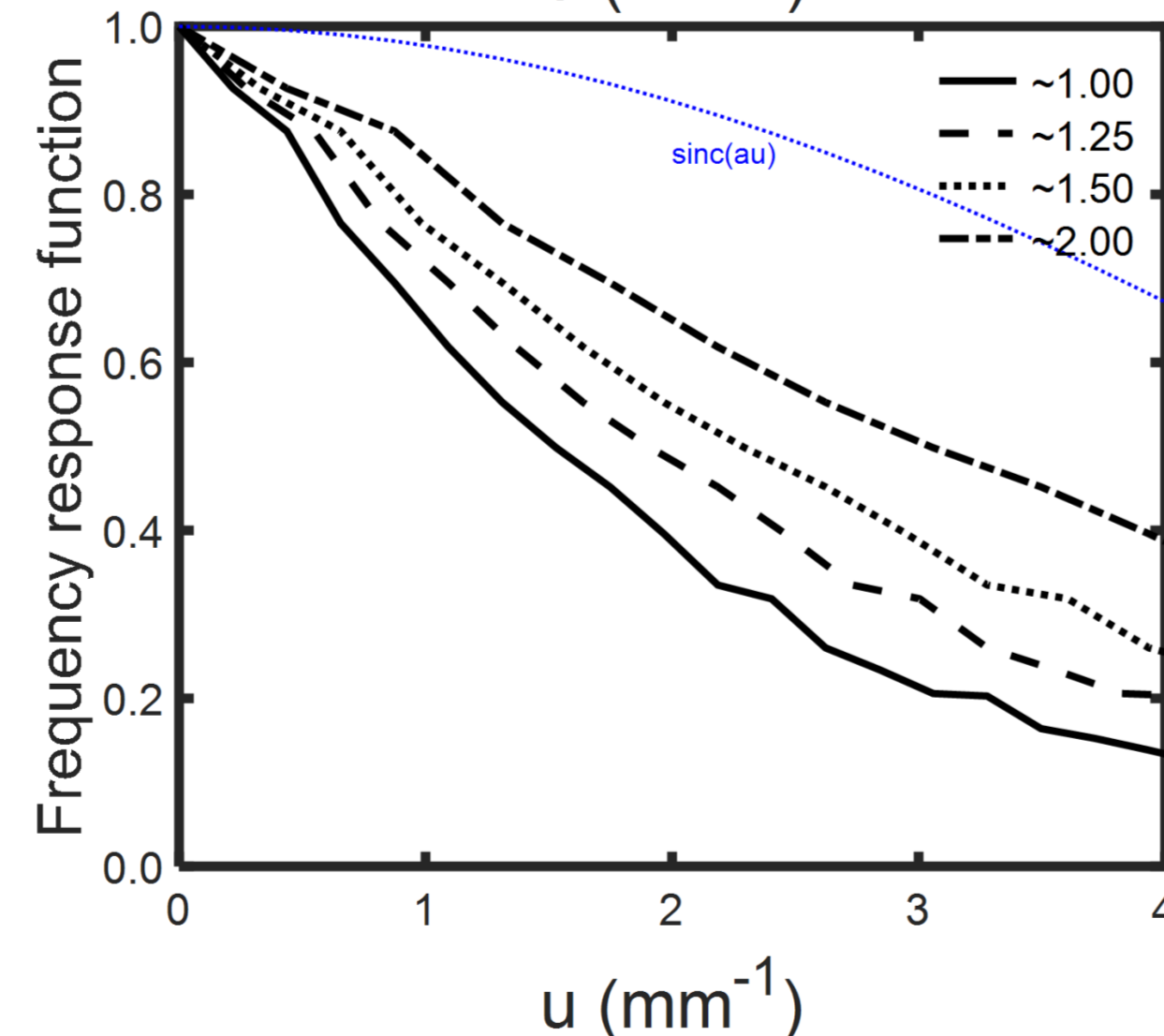
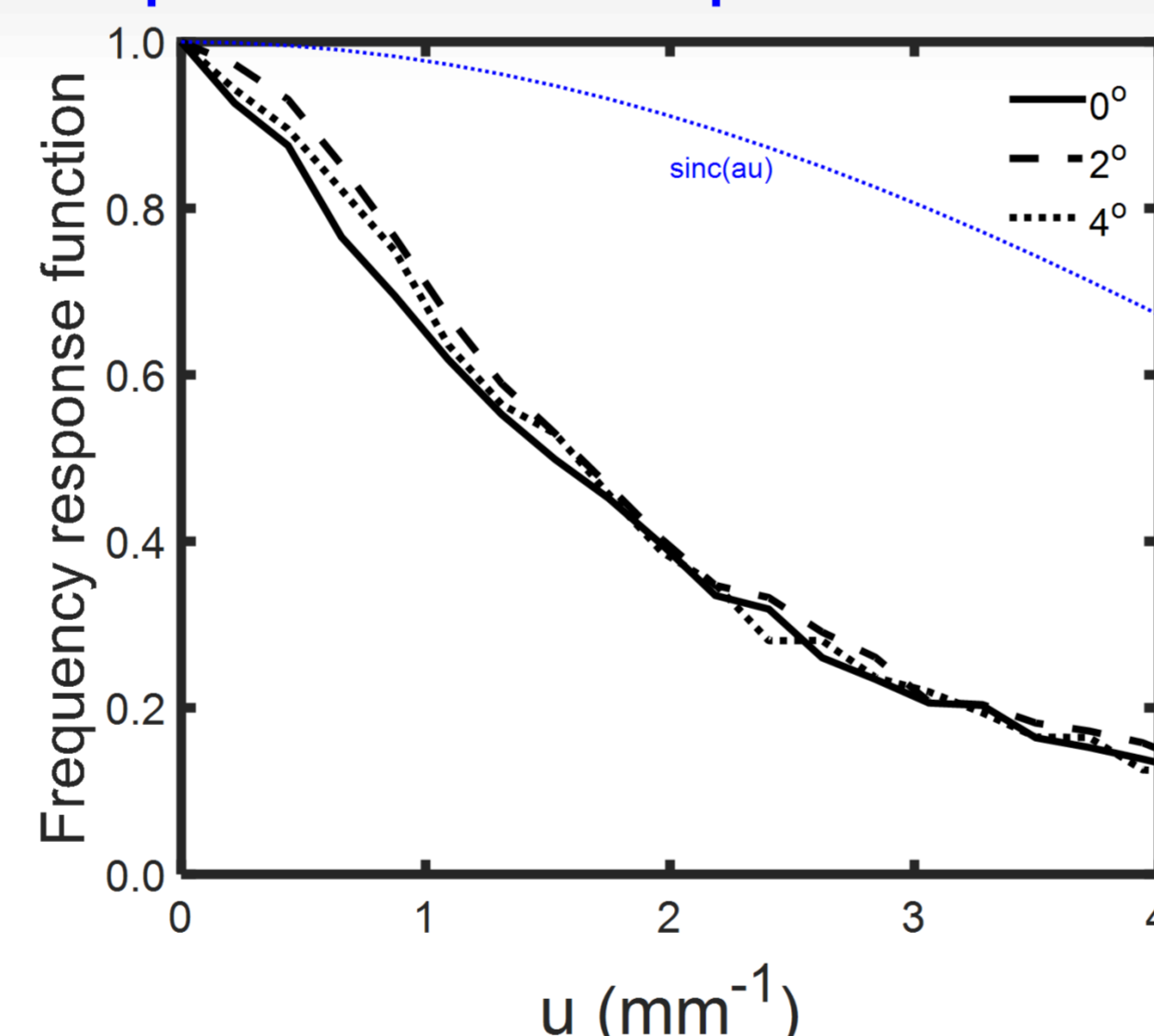
$$A_{eff} (mm) = \left[2\pi \int_0^\infty MTF^2(u) u du \right]^{-1/2}$$

Misalignment

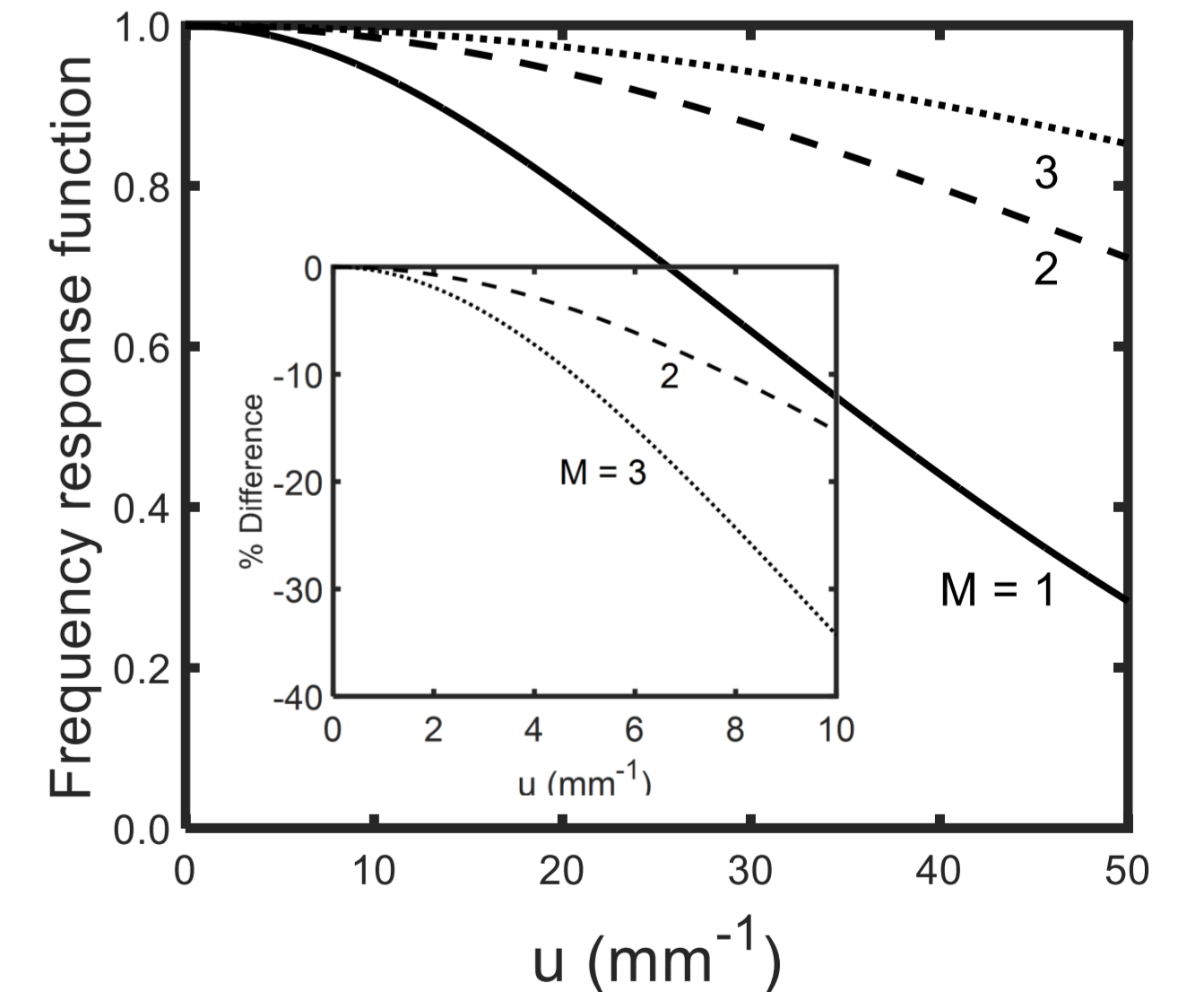
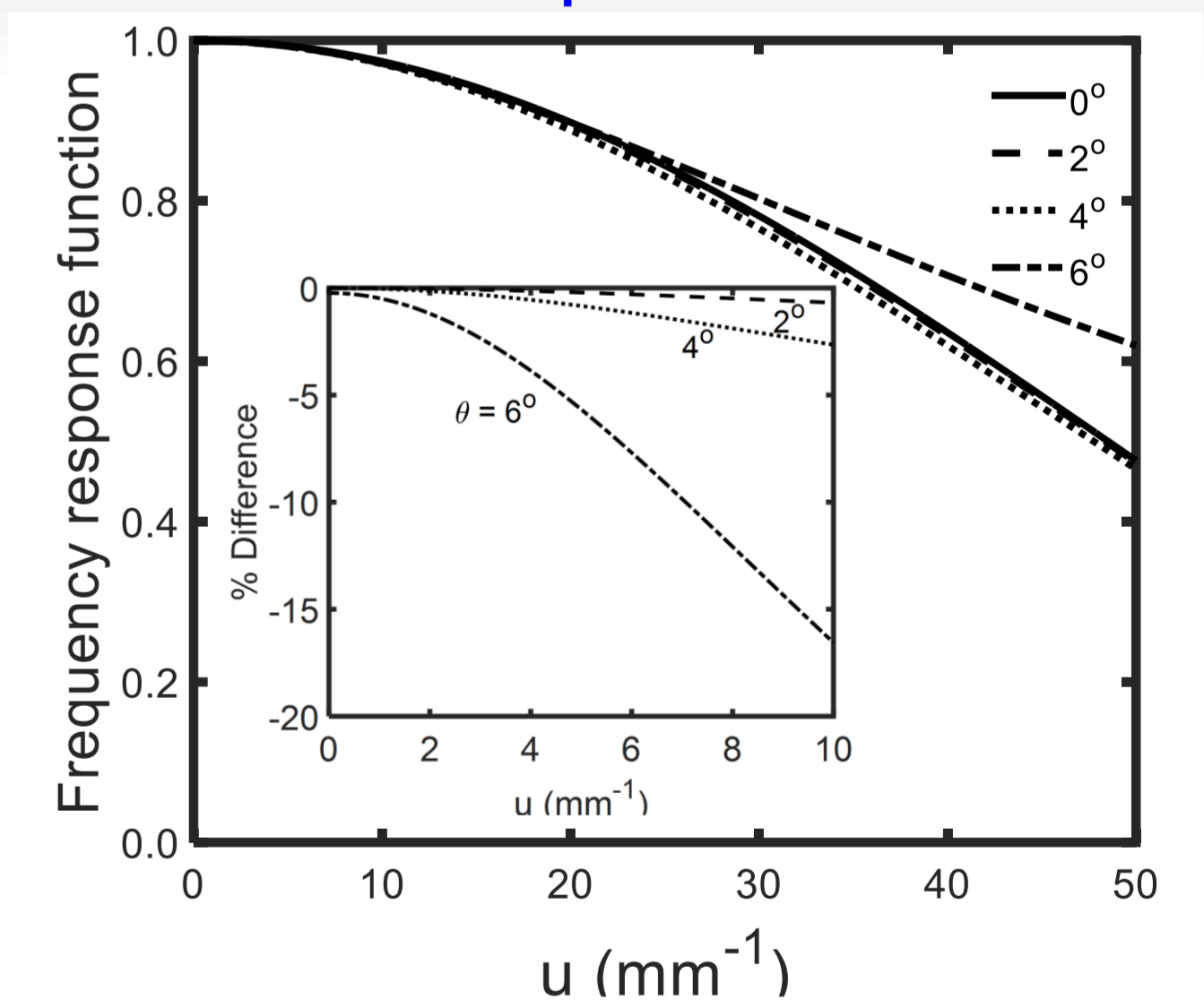
$$Misalignment = \frac{MTF_{\theta^c}(u)}{MTF_{0^c}(u)}$$

Results

Experimental response function



Slit model response function



- The frequency response function is similar for the tilt-angle from 0° to 4°, but that is distorted at specific angle because the x-ray source and center of the slit have misalignment
- The spatial frequency ($f' = mf$) is scaled by magnification. The frequency response function increases according to the magnification

Discussion & Conclusion

- The developed analytic slit-camera MTF model explains well the experimental MTF characteristic for geometrical misalignment (i.e. magnification, tilt-angle)
- The MTF for tilt-angle shows a similar tendency until critical angle ($\theta, \phi = 4^\circ$), but no experimental result was obtained for tilt-angle more than 5°
- Increasing of tilt-angle is followed by a misalignment and the resolution (A_{eff}) characteristic between tilt-angle and magnification in experimental results shows an opposite tendency